Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/681,343	YAMAGUCHI ET AL.	
Examiner	**Art Unit**	
Tran N. Nguyen	2834	

SEARCHED

Class	Subclass	Date	Examiner
310	216 217 254	5/22/05	TNN
	156.47	↓	↓
	156.43	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR